


<p style="text-align: center;">Search Notes</p> 	<p>Application/Control No.</p> <p>10552976</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>MATSUDA, YOJIRO</p>
	<p>Examiner</p> <p>JASON M MANDEVILLE</p>	<p>Art Unit</p> <p>2629</p>

SEARCHED			
Class	Subclass	Date	Examiner
345	107, 84	21 May 2009	Jason Mandeville
430	31-38	21 May 2009	Jason Mandeville
359	296	21 May 2009	Jason Mandeville
345	107, 84	11/18/2009	Jason Mandeville
430	31-38	11/18/2009	Jason Mandeville
359	296	11/18/2009	Jason Mandeville
345	107, 84	09/30/2011	Jason Mandeville
430	31-38	09/30/2011	Jason Mandeville
359	296	09/30/2011	Jason Mandeville

SEARCH NOTES		
Search Notes	Date	Examiner
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	21 May 2009	Jason Mandeville
Inventor Search	21 May 2009	Jason Mandeville
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	11/18/2009	Jason Mandeville
Inventor Search	11/18/2009	Jason Mandeville
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	09/30/2011	Jason Mandeville
Inventor Search	09/30/2011	Jason Mandeville

INTERFERENCE SEARCH

	/JASON MANDEVILLE/ Primary Examiner.Art Unit 2629
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345	107, 84	09/30/2011	Jason Mandeville
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